Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/712,523	FU ET AL.
Examiner	Art Unit

Johannes P. Mondt

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	SEAR	CHED	
Class	Subclass	Date	Examiner
327	534-537	5/24/2005	JPM
257	299	5/24/2005	JPM
257	901	5/24/2005	JPM

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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	DATE	EXMR
NI East data bases, IEEE		
iii East adia 2000, TEEE		
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